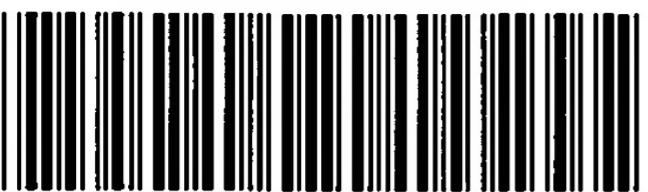


## **Search Notes**



**Application/Control No.**

10/645.618

Examiner

Seungsook Ham

**Applicant(s)/Patent under  
Reexamination**

IIO, KENICHI

## Art Unit

2817

**SEARCHED**

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner